# MOSFET – Power, Dual, N-Channel, ChipFET 30 V, 3.9 A

#### **Features**

- Planar Technology Device Offers Low R<sub>DS(on)</sub> and Fast Switching Speed
- Leadless ChipFET Package has 40% Smaller Footprint than TSOP-6. Ideal Device for Applications Where Board Space is at a Premium.
- ChipFET Package Exhibits Excellent Thermal Capabilities. Ideal for Applications Where Heat Transfer is Required.
- These Devices are Pb-Free and are RoHS Compliant

#### **Applications**

- DC-DC Buck or Boost Converters
- Low Side Switching
- Optimized for Battery and Low Side Switching Applications in Computing and Portable Equipment

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parame  | Symbol                               | Value                 | Unit            |      |    |  |
|---|--------------------------------------|-----------------------|-----------------|------|----|--|
| Drain-to-Source Voltage   | V <sub>DSS</sub>                     | 30                    | V               |      |    |  |
| Gate-to-Source Voltage  |                                      |                       | V <sub>GS</sub> | ±20  | V  |  |
| Continuous Drain  | Steady                               | T <sub>A</sub> = 25°C | I <sub>D</sub>  | 2.9  | Α  |  |
| Current (Note 1)  | State                                | T <sub>A</sub> = 85°C |                 | 2.1  |    |  |
|   | t ≤ 5 s                              | T <sub>A</sub> = 25°C |                 | 3.9  |    |  |
| Power Dissipation (Note 1)  | Steady<br>State                      | T <sub>A</sub> = 25°C | P <sub>D</sub>  | 1.13 | W  |  |
|   | t ≤ 5 s                              | ``                    |                 | 2.1  |    |  |
| Continuous Drain  |                                      | T <sub>A</sub> = 25°C | I <sub>D</sub>  | 2.2  | Α  |  |
| Current (Note 2)  | Steady                               | T <sub>A</sub> = 85°C |                 | 1.6  |    |  |
| Power Dissipation (Note 2)  | State                                | T <sub>A</sub> = 25°C | P <sub>D</sub>  | 0.64 | W  |  |
| Pulsed Drain Current  | t <sub>p</sub> =                     | = 10 μs               | I <sub>DM</sub> | 12   | Α  |  |
| ESD Capability (Note 3)   |                                      | 100 pF,<br>1500 Ω     | ESD-<br>HBM     | 125  | V  |  |
| Operating Junction and S  | T <sub>J</sub> ,<br>T <sub>STG</sub> | –55 to<br>150         | °C              |      |    |  |
| Source Current (Body Di   | IS                                   | 2.5                   | Α               |      |    |  |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) |                                      |                       | TL              | 260  | °C |  |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

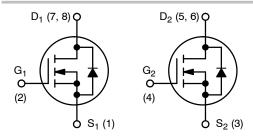
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).
- 3. ESD Rating Information: HBM Class 0.



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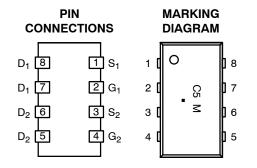
| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> TYP | I <sub>D</sub> MAX |  |
|----------------------|-------------------------|--------------------|--|
| 30 V                 | 80 mΩ @ 10 V            | 3.9 A              |  |
| 00 <b>v</b>          | 110 mΩ @ 4.5 V          | 0.571              |  |



**N-Channel MOSFET** 



ChipFET CASE 1206A STYLE 2



C5 = Specific Device Code

M = Month Code

= Pb-Free Package

#### ORDERING INFORMATION

| Device       | Package              | Shipping <sup>†</sup> |
|--------------|----------------------|-----------------------|
| NTHD4502NT1G | ChipFET<br>(Pb-Free) | 3000/Tape & Reel      |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE RATINGS

| Parameter                                   | Symbol        | Max | Unit |
|---|---------------|-----|------|
| Junction-to-Ambient - Steady State (Note 4) | $R_{	hetaJA}$ | 110 | °C/W |
| Junction-to-Ambient – $t \le 5$ s (Note 4)  | $R_{	hetaJA}$ | 60  |      |
| Junction-to-Ambient - Steady State (Note 5) | $R_{	hetaJA}$ | 195 |      |
| Junction-to-Foot - Steady State (Note 5)    | $R_{	hetaJF}$ | 40  |      |

- 4. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
  5. Surface Mounted on FR4 Board using the minimum recommended pad size (Cu area = 0.214 in sq).

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter                         | Symbol               | Test Conditions   | Min | Тур  | Max  | Units |  |
|-----------------------------------|----------------------|---|-----|------|------|-------|--|
| OFF CHARACTERISTICS               |                      |   |     |      |      |       |  |
| Drain-to-Source Breakdown Voltage | V <sub>(BR)DSS</sub> | $V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$                          | 30  | 36   |      | V     |  |
| Zero Gate Voltage Drain Current   | I <sub>DSS</sub>     | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V                           |     |      | 1.0  | μΑ    |  |
|                                   |                      | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V, T <sub>J</sub> = 125°C   |     |      | 10   |       |  |
| Gate-to-Source Leakage Current    | I <sub>GSS</sub>     | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                       |     |      | ±100 | nA    |  |
| ON CHARACTERISTICS (Note 6)       |                      |   |     |      |      |       |  |
| Gate Threshold Voltage            | V <sub>GS(TH)</sub>  | $V_{GS} = V_{DS}, I_D = 250 \mu A$                                      | 1.0 | 1.65 | 3.0  | V     |  |
| Drain-to-Source On-Resistance     | R <sub>DS(on)</sub>  | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.9 A                          |     | 78   | 85   | mΩ    |  |
|                                   |                      | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 2.2 A                         |     | 105  | 140  |       |  |
| Forward Transconductance          | 9FS                  | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 2.9 A                          |     | 3.8  |      | S     |  |
| CHARGES AND CAPACITANCES          |                      |   | -   |      |      | -     |  |
| Input Capacitance                 | C <sub>ISS</sub>     |   |     | 140  |      | pF    |  |
| Output Capacitance                | C <sub>OSS</sub>     | $V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$<br>$V_{DS} = 15 \text{ V}$ |     | 53   |      |       |  |
| Reverse Transfer Capacitance      | C <sub>RSS</sub>     |   |     | 16   |      |       |  |
| Input Capacitance                 | C <sub>ISS</sub>     |   |     | 135  | 250  | pF    |  |
| Output Capacitance                | C <sub>OSS</sub>     | $V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$<br>$V_{DS} = 24 \text{ V}$ |     | 42   | 75   |       |  |
| Reverse Transfer Capacitance      | C <sub>RSS</sub>     |   |     | 13   | 25   |       |  |
| Total Gate Charge                 | Q <sub>G(TOT)</sub>  |   |     | 3.6  | 7.0  | nC    |  |
| Threshold Gate Charge             | Q <sub>G(TH)</sub>   | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V,                         |     | 0.3  |      |       |  |
| Gate-to-Source Charge             | Q <sub>GS</sub>      | I <sub>D</sub> = 2.9 A  |     | 0.6  |      |       |  |
| Gate-to-Drain Charge              | $Q_{GD}$             |   |     | 0.7  |      |       |  |
| Total Gate Charge                 | Q <sub>G(TOT)</sub>  |   |     | 1.9  |      | nC    |  |
| Threshold Gate Charge             | Q <sub>G(TH)</sub>   | VGS = 4.5 V, VDS = 24 V.  |     | 0.3  |      |       |  |
| Gate-to-Source Charge             | Q <sub>GS</sub>      | $V_{GS} = 4.5 \text{ V}, V_{DS} = 24 \text{ V},$ $I_D = 2.9 \text{ A}$  |     | 0.6  |      | 1     |  |
| Gate-to-Drain Charge              | $Q_{GD}$             | 1   |     | 0.9  |      | 1     |  |

<sup>6.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu s,$  Duty Cycle  $\leq$  2%.

# $\textbf{ELECTRICAL CHARACTERISTICS (continued)} \ \, (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

| Parameter                          | Test Conditions     | Min  | Тур | Max  | Units |    |  |  |
|------------------------------------|---------------------|--|-----|------|-------|----|--|--|
| DRAIN-SOURCE DIODE CHARACTERISTICS |                     |  |     |      |       |    |  |  |
| Forward Diode Voltage              | V <sub>SD</sub>     | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.5 A    |     | 0.85 | 1.2   | V  |  |  |
| Reverse Recovery Time              | t <sub>RR</sub>     | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 2.9 A,   |     | 8.6  |       | ns |  |  |
| Reverse Recovery Charge            | Q <sub>RR</sub>     | $dI_S/dt = 100 A/\mu s$                          |     | 4.0  |       | nC |  |  |
| Reverse Recovery Time              | t <sub>RR</sub>     | V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.0 A,   |     | 8.4  |       | ns |  |  |
| Reverse Recovery Charge            | Q <sub>RR</sub>     | $dI_S/dt = 100 A/\mu s$                          |     | 4.0  |       | nC |  |  |
| SWITCHING CHARACTERISTICS (        | (Note 7)            |  |     |      |       |    |  |  |
| Turn-On Delay Time                 | t <sub>d(ON)</sub>  |  |     | 6.5  | 12    | ns |  |  |
| Rise Time                          | t <sub>r</sub>      | V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 24 V,  |     | 5.4  | 10    |    |  |  |
| Turn-Off Delay Time                | t <sub>d(OFF)</sub> | $I_D = 1 \text{ A}, R_G = 6 \Omega$              |     | 14.9 | 25    |    |  |  |
| Fall Time                          | t <sub>f</sub>      |  |     | 1.8  | 5.0   |    |  |  |
| Turn-On Delay Time                 | t <sub>d(ON)</sub>  |  |     | 7.8  |       | ns |  |  |
| Rise Time                          | t <sub>r</sub>      | V <sub>GS</sub> = 4.5 V, V <sub>DD</sub> = 24 V, |     | 12.6 |       | 1  |  |  |
| Turn-Off Delay Time                | t <sub>d(OFF)</sub> | $I_D = 2.9 \text{ A}, R_G = 2.5 \Omega$          |     | 9.6  |       | 1  |  |  |
| Fall Time                          | t <sub>f</sub>      |  |     | 2.8  |       | 1  |  |  |

<sup>7.</sup> Switching characteristics are independent of operating junction temperatures.

#### TYPICAL PERFORMANCE CURVES

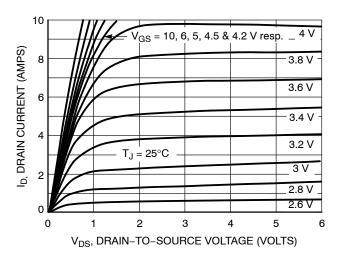


Figure 1. On-Region Characteristics

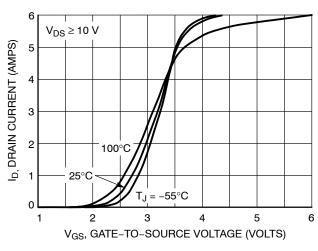


Figure 2. Transfer Characteristics

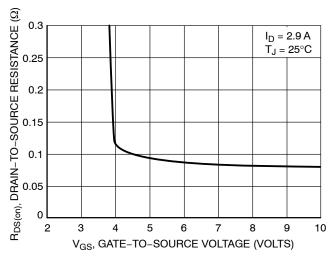


Figure 3. On-Resistance vs. Gate-to-Source Voltage

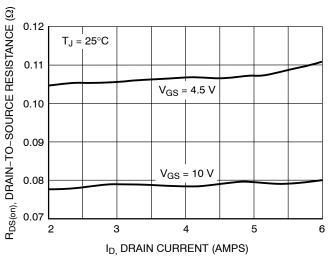


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

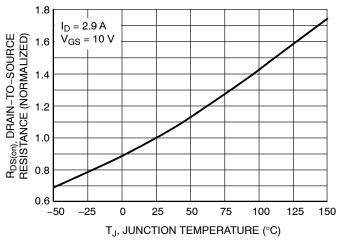


Figure 5. On–Resistance Variation with Temperature

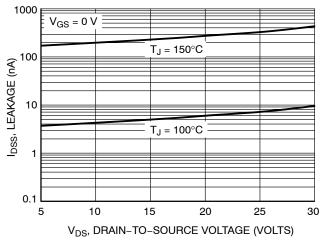
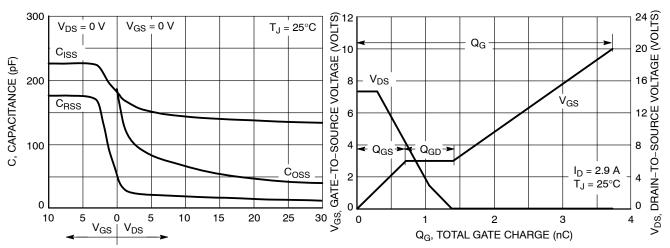


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

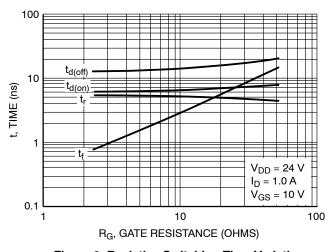


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

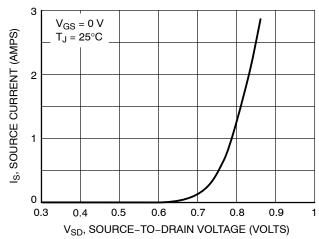
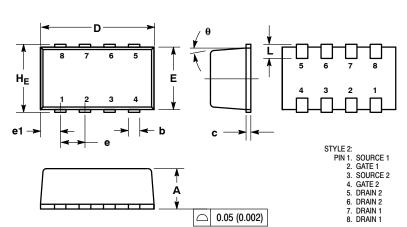


Figure 10. Diode Forward Voltage vs. Current

#### PACKAGE DIMENSIONS

#### **ChipFET™** CASE 1206A-03 ISSUE K



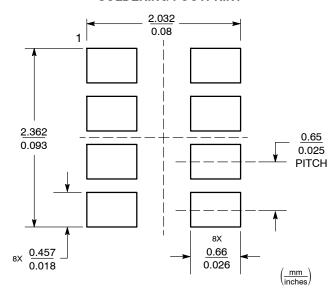
#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982.
- DIMENSIONING AND I OLEHANCING PEH ANS 1914.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
  MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
  LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL
  AND VERTICAL SHALL NOT EXCEED 0.08 MM.
  DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.

- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD

|     | MILLIMETERS        |      |      | INCHES    |       |       |  |
|-----|--------------------|------|------|-----------|-------|-------|--|
| DIM | MIN                | NOM  | MAX  | MIN       | NOM   | MAX   |  |
| Α   | 1.00               | 1.05 | 1.10 | 0.039     | 0.041 | 0.043 |  |
| b   | 0.25               | 0.30 | 0.35 | 0.010     | 0.012 | 0.014 |  |
| С   | 0.10               | 0.15 | 0.20 | 0.004     | 0.006 | 0.008 |  |
| D   | 2.95               | 3.05 | 3.10 | 0.116     | 0.120 | 0.122 |  |
| E   | 1.55               | 1.65 | 1.70 | 0.061     | 0.065 | 0.067 |  |
| е   | 0.65 BSC 0.025 BSC |      |      |           |       |       |  |
| e1  | 0.55 BSC           |      |      | 0.022 BSC |       |       |  |
| L   | 0.28               | 0.35 | 0.42 | 0.011     | 0.014 | 0.017 |  |
| HE  | 1.80               | 1.90 | 2.00 | 0.071     | 0.075 | 0.079 |  |
| θ   | 5° NOM             |      |      | 5° NOM    |       |       |  |

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